Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	pplicant(s)/Patent under eexamination	
10/649,859	SHIN, DONG-WOO		
Examiner	Art Unit		
David Dunn	3616	•	

	SEAR	CHED	
Class	Subclass	Date	Examiner
280	124.107 124.106 124.137	6/22/2005	00
	124.152		
	86.75		
	86.757		
267	189		
Update	4	11/18/05	DD
Update 280	124.135	11/18/05	DD
Update 280	124.135		J DD
	124,136	2/16/06	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
280	124.107	2/16/06	Dr	
	124.137	1	1	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
EAST text search		6/22/2005	DO	
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